Inverse spin Hall effect measurements in patterned Ni₈₀Fe₂₀/normal metal bilayers*

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Recent activity in spin transport research has included a focus on spin Hall effects, which arise from spin-orbit interactions, rather than exchange or spin-lattice effects. Spin orbit coupling in normal metals (NM) leads to a conversion of pure spin current into a charge current, which is perpendicular to both the spin current direction and the spin polarization. This is known as the inverse spin Hall effect and it generates a voltage across a spin-current-carrying sample. The strength of the inverse spin Hall effect is characterized by a single dimensionless parameter, the spin Hall angle, which is materials-specific. We studied the inverse spin Hall effect in Ni₈₀Fe₂₀/NM bilayer structures by generating pure spin currents inside the NM layer through spin pumping at the $Ni_{80}Fe_{20}/NM$ interface. Integrating a patterned $Ni_{80}Fe_{20}/NM$ bilayer into a coplanar waveguide transmission line enables us to excite large angle magnetization precession in $Ni_{80}Fe_{20}$ via rf excitation, which in turn generates a dc spin current in the adjacent NM. Ferromagnetic resonance (FMR) in Ni₈₀Fe₂₀ and the dc voltage across the Ni₈₀Fe₂₀/NM were measured simultaneously as a function of the applied magnetic field. A strong dcsignal across the Ni₈₀Fe₂₀/NM is observed at the FMR position, and its magnitude is dependent on the power of the *rf* excitation and the angle of the applied magnetic field. We identified two distinct contributions to the *dc* voltage: one symmetric with respect to the FMR resonance position, and the other antisymmetric. Our analysis shows that the antisymmetric contribution is due to an anisotropic magnetoresistance effect (AMR) in the Ni₈₀Fe₂₀ layer and is present even in single-layer Ni₈₀Fe₂₀ films. The second, symmetric, contribution to the measured *dc* voltage is attributed to the inverse spin Hall effect. The sign and strength of the symmetric contribution is dependent on the NM used in the experiment; we uniquely determine in quantitative fashion compared to other studies, the spin Hall angle for Pt, Au and Mo by fitting the experimental data to a selfconsistent theory, which accounts for both the AMR and inverse spin Hall effect contributions. This study provides insight for identifying materials that are useful for spintronic applications.

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